



<p style="text-align: center;"><b>Searched</b></p> 	Application/Control No.  10777142	Applicant(s)/Patent Under Reexamination  IDE ET AL.
	Examiner Al-Nazer, Leith A	Art Unit 2821

Class	SubClass	Date	Examiner
349	149-152	07/19/2006	Leith Al-Nazer

U.S. Patent and Trademark Office	Part of Paper No.: 20060719
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<p><b>Search Notes</b></p> 	<p>Application/Control No.</p> <p>10777142</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>IDE ET AL.</p>
	<p>Examiner</p> <p>Al-Nazer, Leith A</p>	<p>Art Unit</p> <p>2821</p>

Notes	Date	Examiner
Updated EAST prior art text search (see "Examiner Search Notes")	07/19/2006	Leith Al-Nazer
U.S. Patent and Trademark Office	Part of Paper No.:	20060719